

 Test report No.
 : 26FE0204-HO-C

 Page
 : 1 of 72

 Issued date
 : June 21, 2006

 FCC ID
 : T87SS22BXXXM

SAR TEST REPORT

Test Report No.: 26GE0204-HO-C

Applicant : FURUNO SYSTEMS CO.,LTD.

Type of Equipment : WLAN module

Model No. : ATC-BICF

FCC ID : T87SS22BXXXM

Test standard : FCC47CFR 2.1093

FCC OET Bulletin 65, Supplement C

Test Result : Complied

Max. SAR Measured : 0.564W/kg (Body, 2412MHz)

- 1. This test report shall not be reproduced except full or partial, without the written approval of UL Apex Co., Ltd.
- 2. The results in this report apply only to the sample tested.
- 3. This equipment is in compliance with the above standard. We hereby certify that the data contain a true representation of the SAR profile.
- 4. The test results in this test report are traceable to the national or international standards.

Date of test:

February 28, 2006

Tested by:

Hisayoshi Sato EMC Services

Approved by:

J. Maeno

Tetsuo Maeno Site Manager of EMC Services



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.

*As for the range of Accreditation in NVLAP, you may refer to the WEB address, http://ulapex.jp/emc/nvlap.htm

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Page : 2 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

<u>CONTENTS</u> PAGE

	Client information	3
CECTION 2		2
SECTION 2:	Equipment under test (E.U.T.)	3
2.1	Identification of E.U.T.	3
2.2	Product description	
2.3	Host device	
SECTION 3:	Test standard information	5
3.1	Requirements for compliance testing defined by the FCC	
3.2	Exposure limit	
SECTION 4:	Test result	7
4.1	Result of Max. SAR value	7
4.1	Test location	
SECTION 5:	Operation of E.U.T. during testing	
2201101101	operation of Electric warring tolding.	
5.1	Operating modes.	7
5.2	Measurement procedure	
5.4	Test setup of EUT	9
SECTION 6:	Test surrounding	10
	Measurement uncertainty	
SECTION 7:	Confirmation before testing	11
7.1	Conducted power	11
/.1	Conducted power	1 1
SECTION 8 ·	Measurement results	
SECTION 8:	Measurement results	
		12
8.1	SAR measurement results	12
8.1 APPENDIX 1 APPENDIX 2	SAR measurement results	12 13 27
8.1 APPENDIX 1 APPENDIX 2	SAR measurement results 1: Photographs of test setup	
8.1 APPENDIX 1 APPENDIX 2 E	SAR measurement results 1: Photographs of test setup	
8.1 APPENDIX 1 APPENDIX 2 E 1.	SAR measurement results 1: Photographs of test setup	
8.1 APPENDIX 1 APPENDIX 2 E 1. 2.	SAR measurement results 1: Photographs of test setup	
8.1 S APPENDIX 1 APPENDIX 2 1. 2. 3. 4.	SAR measurement results 1: Photographs of test setup	
8.1 S APPENDIX 1 APPENDIX 2 E 1. 2. 3. 4.	SAR measurement results 1: Photographs of test setup	
8.1 S APPENDIX 1 APPENDIX 2 E 1. 2. 3. 4. 5.	SAR measurement results 1: Photographs of test setup 2: Test instruments quipment & calibration information Equipment used Dosimetry assessment setup Configuration and peripherals System components Test system specifications Simulated tissues composition of 2450MHz	12 12 13 13 27 28 28 29 29 30 31 33 33 35 35
8.1 3 APPENDIX 2 APPENDIX 2 1. 2. 3. 4. 5. 6. 7.	SAR measurement results. 1: Photographs of test setup	12 12 13 13 27 28 28 29 29 30 31 33 35 35 35
8.1 3 APPENDIX 2 APPENDIX 2 1. 2. 3. 4. 5. 6. 7. 8.	SAR measurement results I: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 3 APPENDIX 2 E 1. 2. 3. 4. 5. 6. 7. 8. 9.	SAR measurement results. 1: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 3 APPENDIX 1 APPENDIX 2 E 1. 2. 3. 4. 5. 6. 7. 8.	SAR measurement results I: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 3 APPENDIX 1 APPENDIX 2 1. 2 3. 4 5. 6 7. 8 9. 10	SAR measurement results. 1: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 3 APPENDIX 1 APPENDIX 2 1. 2. 3. 4. 5. 6. 7. 8. 9. 10 1. 12	SAR measurement results I: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 3 APPENDIX 1 APPENDIX 2 1. 2. 3. 4. 5. 6. 7. 8. 9. 10 1. 12 12 12 12 12 12 12 12 12 12 12 12 12	SAR measurement results. 1: Photographs of test setup	12 12 13 13 14 15 15 15 15 15 15 15 15 15 15 15 15 15
8.1 S APPENDIX 1 APPENDIX 2 1. 2. 3. 4. 5. 6. 7. 8. 9. 10 1 1 12 APPENDIX 3	SAR measurement results. 1: Photographs of test setup	12 12 13 13 13 13 13 13 13 13 13 13 13 13 13

UL Apex Co., Ltd.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 3 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

SECTION 1: Client information

Company Name	FURUNO SYSTEMS CO., LTD.
Address	9-52, Ashihara-town, Nishinomiya-city, Hyogo, 662-8580 JAPAN
Telephone Number	+81-798-63-1194
Facsimile Number	+81-798-63-1197
Contact Person	Takeaki Okamoto

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	WLAN module
Model No.	ATC-BICF
Serial No.	44502809
Country of Manufacture	Japan
Rating	DC 3.3V +/-5%
Receipt Date of Sample	February 21, 2006
Condition of EUT	Production model
Category Identified	Portable device & Mobile device
Modification of EUT	No modification by the test lab.

2.2 Product description

2.2.1 General Information

Feature of EUT	The EUT is IEEE802.11b WLAN module and is installed only in Handy		
	Terminal manufactured by FURUNO SYSTEMS CO., LTD.		
Size	About 55 (W)*36 (H)*2.5 (D) mm		
Range of	-20deg. C. to +60 deg. C.		
operation temperature			
Operation Clock	44MHz		

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 26FE0204-HO-C Page : 4 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

2.2.2 Radio specification

Type of radio	Wireless LAN
	(IEEE802.11b)
Equipment Type	Transceiver
Frequency band	2400-2483.5MHz
Frequency of Operation	2412-2462MHz
Bandwidth	20MHz & 5MHz
& Channel spacing	
Type of Modulation	DSSS
Antenna Type	Chip Antenna (DA150S-2450G-FS02)
Antenna Connector Type	U.FL connector (AYU1-1P-02676-120)
Antenna Gain	2dBi (Max)
ITU code	G1D
Max. Output Power	16.2dBm (41.69mW)
(Peak)	
Power Supply	DC +3.3V +/-5%
Method of	Synthesizer
Frequency Generation	

2.3 Host device

2.3.1 Information of host deveice

The EUT will be installed only in PI-13500-W and PI-13503-W(Type of Equipment: Handy Terminal) which is manufactured by FURUNO SYSTEMS CO., LTD.

The details of Handy Terminal used for SAR test are shown in the following table.

T CF insured	II1 T				
Type of Equipment	Handy Terminal				
Manufacture	FURUNO SYSTEMS CO., LTD.				
Model No.	PI-13500-W				
Serial No.	7038-6349				
Battery	Type : Li-ion Battery				
	Model name : BP-12000				
	V/Ah : DC3.7V 1800mAh				
Operation Clock	Bus: 29.4912MHz				
	CPU_INT(Max): 117.9648MHz				
Size	75 (W)*204 (H)*50 (D) mm				
Position of Antenna	See APPENDIX 1.				
The shortest distance	7.9mm				
between surface of host device					
and antenna					

^{*} PI-13503-W is equivalent model to PI-13500-W. PI-13500-W was tested as a representative.

Model No. PI-13503-W has a series model as Model No. PI-13500-W.

PI-13500-W was tested as a representative model.

PI-13503-W has a function of two-dimensional scanning, and PI-13500-W has a function of one-dimensional scanning.

These two models are same in the exterior and the antenna position.

As a result of the test, the SAR values are equivalent in these two.

The photograph of the EUT and the host device is put on "APPENDIX 1"

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 5 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

SECTION 3: Test standard information

3.1 Requirements for compliance testing defined by the FCC

The US Federal Communications Commission has released the report and order "Guidelines for Evaluating the Environmental Effects of RF Radiation", ET Docket No. 93-62 in August 1996. The order requires routine SAR evaluation prior to equipment authorization of portable transmitter devices, including portable telephones. For consumer products, the applicable limit is 1.6 mW/g for an uncontrolled environment and 8.0 mW/g for an occupational/controlled environment as recommended by the ANSI/IEEE standard C95.1-1992. According to the Supplement C of OET Bulletin 65 "Evaluating Compliance with FCC Guide-lines for Human Exposure to Radio frequency Electromagnetic Fields", released on Jun 29, 2001 by the FCC, the device should be evaluated at maximum output power (radiated from the antenna) under "worst-case" conditions for normal or intended use, incorporating normal antenna operating positions, device peak performance frequencies and positions for maximum RF energy coupling.

1 Specific Absorption Rate (SAR) is a measure of the rate of energy absorption due to exposure to an RF transmitting source (wireless portable device).

2 IEEE/ANSI Std. C95.1-1992 limits are used to determine compliance with FCC ET Docket 93-62.

UL Apex Co., Ltd. Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 6 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

3.2 Exposure limit

(A) Limits for Occupational/Controlled Exposure (W/kg)

Spatial Average (averaged over the whole body)	Spatial Peak (averaged over any 1g of tissue)	Spatial Peak (hands/wrists/feet/ankles averaged over 10g)	
0.4	8.0	20.0	

(B) Limits for General population/Uncontrolled Exposure (W/kg)

Spatial Average (averaged over the whole body	Spatial Peak (averaged over any 1g of tissue)	Spatial Peak (hands/wrists/feet/ankles averaged over 10g)
0.08	1.6	4.0

Occupational/Controlled Environments: are defined as locations where there is exposure that may be incurred by people who are aware of the potential for exposure, (i.e. as a result of employment or occupation).

General Population/Uncontrolled Environments: are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure.

NOTE:GENERAL POPULATION/UNCONTROLLED EXPOSURE SPATIAL PEAK(averaged over any 1g of tissue) LIMIT 1.6 W/kg

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

 Test report No.
 : 26FE0204-HO-C

 Page
 : 7 of 72

 Issued date
 : June 21, 2006

 FCC ID
 : T87SS22BXXXM

SECTION 4: Test result

4.1 Result of Max. SAR value

Max. SAR Measured : 0.564 W/kg (Body, 2412MHz)

4.2 Test location

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Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

SECTION 5: Operation of E.U.T. during testing

5.1 Operating modes

Operation mode	The frequency band and the modulation used in this test are shown as a following.					
	Frequency band Channel Modulation Crest factor	: 2412-2462MHz : Low ch(2412MHz), Mid ch(2437MHz), High ch(2462MHz) : DSSS : 1				

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 26FE0204-HO-C Page : 8 of 72

Issued date : June 21, 2006 FCC ID : T87SS22BXXXM

5.2 Measurement procedure

1. Confirmation before testing

Conducted power was measured before SAR testing.

Variation between the measured power level and one of EMC Test was within 0~+5%. (FCC requirements)

However, the data of EMC test is used as a substitute for SAR test when there is no possibility in power change obviously as follows:

- EMC and SAR tests are performed with the same test sample under the same condition.
- EMC and SAR tests are performed at the same laboratory.
- The test mode setting is simple, and there is no possibility that the power (value) is changed by the wrong setting.

2. SAR Measurement (Radiated power is always monitored by Spectrum Analyzer.)

Step1. Worst position search

The frequency was set to Mid Channel, and the position that has the maximum SAR value was detected.

Step2. Change channels

Test was performed using Low/High channels at the position of the maximum value.

Step3. Change separations

The measurement was performed with the distance, 5mm, 10mm and 15mm to check if the shortest distance (0mm) may not have the worst value at the conditions of the highest SAR value. As a result, the shortest distance (0mm) had the worst value

*It is checked that the power drift value at each measurement is within $\pm 5\%$ as to the power change before and after the SAR test. When the power drift value is over $\pm -5\%$, the power changes against time is measured to confirm the changes are within tolerance.

Moreover, the change rate is reflected on the uncertainty.

UL Apex Co., Ltd. Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

 Test report No.
 : 26FE0204-HO-C

 Page
 : 9 of 72

 Issued date
 : June 21, 2006

 FCC ID
 : T87SS22BXXXM

5.4 Test setup of EUT

We tested the Handy Terminal (Model No.: PI-13500-W) with which this EUT was inserted.

When users operate or carry the EUT, it could be considered to touch or get close to their bodies. In order to assume this situation, we performed the test at the following positions. Please refer to "APPENDIX 1" for more details.

(1) Front:

The test was performed in touch with Front surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(2) Back

The test was performed in touch with Back surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(3) Left Side:

The test was performed in touch with Left Side surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(4) Right Side:

The test was performed in touch with Right Side surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(5) Top:

The test was performed in touch with Top surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(6) Bottom:

The test was performed in touch with Bottom surface of the Handy Terminal to the flat section of SAM Twin Phantom.

(7) Top (Separation 5mm, 10mm, 15mm):

The test was performed in the separation of 5mm, 10mm, 15mm between EUT and flat sections of the SAM Twin Phantom

UL Apex Co., Ltd. Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 26FE0204-HO-C
Page : 10 of 72
Issued date : June 21, 2006
FCC ID : T87SS22BXXXM

SECTION 6: Test surrounding

6.1 Measurement uncertainty

The uncertainty budget has been determined for the DASY4 measurement system according to the SPEAG documents [6][7] and is given in the following Table.

Walue ± %distributionMeasurement System±6.8NormalProbe calibration±6.8NormalAxial isotropy of the probe±4.7RectangeSpherical isotropy of the probe±9.6RectangeBoundary effects±2.0RectangeProbe linearity±4.7RectangeDetection limit±1.0RectangeReadout electronics±1.0NormalResponse time±0.8RectangeIntegration time±2.6RectangeRF ambient Noize±3.0RectangeRF ambient Reflections±3.0RectangeMech. constraints of robot±0.8RectangeProbe positioning±9.9RectangeExtrap. and integration±4.0RectangeTest Sample RelatedTest Sample RelatedDevice positioning±2.9NormalDevice holder uncertainty±3.6NormalPhantom and SetupPhantom and SetupPhantom uncertainty±5.0RectangeLiquid conductivity (target)±5.0RectangeLiquid conductivity (target)±5.0RectangeLiquid permittivity (target)±5.0RectangeLiquid permittivity (meas.)±5.0Normal	ty divisor	(ci)	Standard	vi
Probe calibration	on	1g	Uncertainty (1g)	or veff
Axial isotropy of the probe			(-6)	7011
Spherical isotropy of the probe Boundary effects Boundary effects Probe linearity Detection limit #4.7 Rectanguman Rectanguman Readout electronics Response time #4.8 Rectanguman Rectanguman Rectanguman Response time #4.0 Response time #4.0 #4.0 #4.0 #4.0 ##4.	1	1	±6.8	∞
Boundary effects ±2.0 Rectanguments Probe linearity ±4.7 Rectanguments Detection limit ±1.0 Rectanguments Readout electronics ±1.0 Normal Response time ±0.8 Rectanguments Integration time ±2.6 Rectanguments RF ambient Noize ±3.0 Rectanguments RF ambient Reflections ±3.0 Rectanguments Mech. constraints of robot ±0.8 Rectanguments Probe positioning ±9.9 Rectanguments Extrap. and integration ±4.0 Rectanguments Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectanguments Phantom and Setup Phantom uncertainty ±4.0 Rectanguments Liquid conductivity (target) ±5.0 Rectanguments Liquid conductivity (meas.) ±5.0 Rectanguments Liquid permittivity (target) ±5.0 Rectanguments Liquid permittivity (targ	ılar √3	0.7	±1.9	∞
Probe linearity ±4.7 Rectangument Detection limit ±1.0 Rectangument Readout electronics ±1.0 Normal Response time ±0.8 Rectangument Integration time ±2.6 Rectangument RF ambient Noize ±3.0 Rectangument RF ambient Reflections ±3.0 Rectangument Mech. constraints of robot ±0.8 Rectangument Probe positioning ±9.9 Rectangument Extrap. and integration ±4.0 Rectangument Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectangument Phantom and Setup Phantom uncertainty ±4.0 Rectangument Liquid conductivity (target) ±5.0 Rectangument Liquid conductivity (meas.) ±5.0 Rectangument Liquid permittivity (target) ±5.0 Rectangument Liqu	ılar √3	0.7	±3.9	∞
Detection limit ±1.0 Rectangument	ılar √3	1	±1.2	∞
Readout electronics ±1.0 Normal Response time ±0.8 Rectangu Integration time ±2.6 Rectangu RF ambient Noize ±3.0 Rectangu RF ambient Reflections ±3.0 Rectangu Mech. constraints of robot ±0.8 Rectangu Probe positioning ±9.9 Rectangu Extrap. and integration ±4.0 Rectangu Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectangu Phantom and Setup Phantom uncertainty ±4.0 Rectangu Liquid conductivity (target) ±5.0 Rectangu Liquid conductivity (meas.) ±5.0 Rectangu Liquid permittivity (target) ±5.0 Rectangu Liquid permittivity (target) ±5.0 Rectangu Liquid permittivity (target) ±5.0 Rectangu	ılar √3	1	±2.7	∞
Response time	ılar √3	1	±0.6	∞
Integration time	1	1	±1.0	∞
RF ambient Noize ±3.0 Rectangument Reflections ±3.0 Rectangument Reflections ±3.0 Rectangument Reflections ±0.8 Rectangument Rectangument Reflections ±0.8 Rectangument Rectan	ılar √3	1	±0.5	∞
RF ambient Reflections ±3.0 Rectangument Reflections ±0.8 Rectangument Reflections ±0.8 Rectangument Reflectioning ±9.9 Rectangument Restrap. and integration ±4.0 Rectangument Restrap. Test Sample Related Extrap. Sample Related Extrap. Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectangument Rectangument Rectangument Extrap. Extra	ılar √3	1	±1.5	∞
Mech. constraints of robot ±0.8 Rectangument Probe positioning ±9.9 Rectangument Extrap. and integration ±4.0 Rectangument Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectangument Phantom and Setup Phantom uncertainty ±4.0 Rectangument Liquid conductivity (target) ±5.0 Rectangument Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectangument Extrap. Section Extra	ılar √3	1	±1.7	∞
Probe positioning ±9.9 Rectanguments Extrap. and integration ±4.0 Rectanguments Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectanguments Phantom and Setup Phantom uncertainty ±4.0 Rectanguments Liquid conductivity (target) ±5.0 Rectanguments Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectanguments Extrap. 19.9 Rectanguments Extrap. 29.9 Rectanguments Extrap. 20.9 Rectanguments Extrap	ılar √3	1	±1.7	∞
Extrap. and integration ±4.0 Rectange Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectange Phantom and Setup Phantom uncertainty ±4.0 Rectange Liquid conductivity (target) ±5.0 Rectange Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectange	ılar √3	1	±0.5	∞
Test Sample Related Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectange Phantom and Setup Phantom uncertainty ±4.0 Rectange Liquid conductivity (target) ±5.0 Rectange Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectange	ılar √3	1	±5.7	∞
Device positioning ±2.9 Normal Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectange Phantom and Setup Phantom uncertainty ±4.0 Rectange Liquid conductivity (target) ±5.0 Rectange Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectange	ılar √3	1	±2.3	∞
Device holder uncertainty ±3.6 Normal Power drift ±5.0 Rectangu Phantom and Setup Phantom uncertainty ±4.0 Rectangu Liquid conductivity (target) ±5.0 Rectangu Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectangu				
Power drift ±5.0 Rectange Phantom and Setup Phantom uncertainty ±4.0 Rectange Liquid conductivity (target) ±5.0 Rectange Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectange	1	1	±2.9	10
Phantom and Setup Phantom uncertainty ±4.0 Rectangu Liquid conductivity (target) ±5.0 Rectangu Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectangu	1	1	±3.6	8
Phantom uncertainty ±4.0 Rectangu Liquid conductivity (target) ±5.0 Rectangu Liquid conductivity (meas.) ±5.0 Normal Liquid permittivity (target) ±5.0 Rectangu	ılar √3	1	±2.9	∞
Liquid conductivity (target) ± 5.0 RectangeLiquid conductivity (meas.) ± 5.0 NormalLiquid permittivity (target) ± 5.0 Rectange				
Liquid conductivity (meas.) ± 5.0 NormalLiquid permittivity (target) ± 5.0 Rectange	ılar √3	1	±2.3	∞
Liquid permittivity (target) ±5.0 Rectangu	ılar √3	0.64	±1.8	∞
	1	0.64	±3.2	∞
Liquid permittivity (meas.) ±5.0 Normal	ılar √3	0.6	±1.7	∞
	1	0.6	±3.0	∞
Combined Standard Uncertainty			±13.515	
Expanded Uncertainty (k=2)			±13.313	

UL Apex Co., Ltd. Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 26FE0204-HO-C
Page : 11 of 72
Issued date : June 21, 2006
FCC ID : T87SS22BXXXM

SECTION 7: Confirmation before testing

7.1 Conducted power

Date: February 21, 2006

[IEEE 80.2 11b] Conducted power							
Ch	Modulation	P/M	Cable	Atten.	Result	Result	
	(Data rate [Mbps])	Reading	Loss				
		[dBm]	[dB]	[dB]	[dBm]	[mW]	
Mid	DBPSK(1)	-7.80	0.70	19.88	12.78	18.97	
Mid	DQPSK(2)	-7.23	0.70	19.88	13.35	21.63	
Mid	CCK(5.5)	-5.01	0.70	19.88	15.57	36.06	
Mid	CCK(11)	-4.72	0.70	19.88	15.86	38.55	

[IEEE 80.2 11b] Conducted power							
Ch	Modulation	P/M	Cable	Atten.	Result	Result	
	(Data rate [bps])	Reading	Loss				
		[dBm]	[dB]	[dB]	[dBm]	[mW]	
Low	CCK(11)	-4.37	0.70	19.87	16.20	41.69	
Mid	CCK(11)	-4.72	0.70	19.88	15.86	38.55	
High	CCK(11)	-5.31	0.70	19.88	15.27	33.65	

Sample Calculation:

Result [dBm] = Reading + Cable Loss (supplied by customer)+ Attenuator

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

^{*} This data is the measured Maximum Peak OutPut Power of EMC Test. (Reference Report No. 26GE0204-HO-A)

Test report No. : 26FE0204-HO-C
Page : 12 of 72
Issued date : June 21, 2006
FCC ID : T87SS22BXXXM

SECTION 8: Measurement results

8.1 SAR measurement results

All of power drifts were within $\pm 5\%$ in SAR tests . The measurement data is put on "APPENDIX 3".

8.1.1 Body 2450MHz SAR

Body 2450MHz SAR

Date February 28, 2006 Measured By Hisayoshi Sato Liquid Depth (cm) 15.3 Model ATC-BICF $\varepsilon_r = 50.3, \ \sigma = 1.86$ Serial No. 44502809 **Parameters** Ambient temperature (deg.c.) 25.0 Modulation DSSS : 32 : 1 Relative Humidity (%) Crest factor

BODY SAR MEASUREMENT RESULTS									
Frequency				Dhantan	EUT Set-up Conditions		Liquid Temp.[deg.c]		SAR(1g) [W/kg]
Band	Channel	[MHz]	Modulation	Phantom Section	Position	Separation [mm]	Before	After	value of multi-peak
11b	Worst position search								
	Mid	2437	CCK(11Mbps)	Flat	Front	0	23.7	23.7	0.148
	Mid	2437	CCK(11Mbps)	Flat	Back	0	23.7	23.7	0.030
	Mid	2437	CCK(11Mbps)	Flat	Left side	0	23.5	23.5	0.033
	Mid	2437	CCK(11Mbps)	Flat	Right side	0	23.5	23.5	0.047
	Mid	2437	CCK(11Mbps)	Flat	Тор	0	23.4	23.4	0.490
	Mid	2437	CCK(11Mbps)	Flat	Bottom	0	23.4	23.4	0.00464
	Change channels								
	Low	2412	CCK(11Mbps)	Flat	Тор	0	23.5	23.5	0.564
	High	2462	CCK(11Mbps)	Flat	Тор	0	23.5	23.5	0.352
	Change separations								
	Low	2412	CCK(11Mbps)	Flat	Тор	5	23.5	23.5	0.107
	Low	2412	CCK(11Mbps)	Flat	Тор	10	23.5	23.5	0.077
	Low	2412	CCK(11Mbps)	Flat	Тор	15	23.5	23.5	0.031
									R: 1.6 W/kg over 1 gram)

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